



# STD8N65M5, STF8N65M5, STI8N65M5 STP8N65M5, STU8N65M5

N-channel 650 V, 0.56  $\Omega$ , 7 A MDmesh™ V Power MOSFET  
in I<sup>2</sup>PAK, TO-220, TO-220FP, DPAK and IPAK

Preliminary data

## Features

Type	$V_{DSS}$ @ $T_{Jmax}$	$R_{DS(on)}$ max	$I_D$
STD8N65M5	710 V	< 0.6 $\Omega$	7 A
STF8N65M5	710 V	< 0.6 $\Omega$	7 A <sup>(1)</sup>
STI8N65M5	710 V	< 0.6 $\Omega$	7 A
STP8N65M5	710 V	< 0.6 $\Omega$	7 A
STU8N65M5	710 V	< 0.6 $\Omega$	7 A

1. Limited only by maximum temperature allowed

- Worldwide best  $R_{DS(on)}$ \* area
- Higher  $V_{DSS}$  rating
- High dv/dt capability
- Excellent switching performance
- Easy to drive
- 100% avalanche tested

## Application

- Switching applications

## Description

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MDmesh™ V is a revolutionary Power MOSFET technology based on an innovative proprietary vertical process, which is combined with STMicroelectronics' well-known PowerMESH™ horizontal layout structure. The resulting product has extremely low on-resistance, which is unmatched among silicon-based Power MOSFETs, making it especially suitable for applications which require superior power density and outstanding efficiency.

Table 1. Device summary

Order codes	Marking	Package	Packaging
STD8N65M5	8N65M5	DPAK	Tape and reel
STF8N65M5	8N65M5	TO-220FP	Tube
STI8N65M5	8N65M5	I <sup>2</sup> PAK	Tube
STP8N65M5	8N65M5	TO-220	Tube
STU8N65M5	8N65M5	IPAK	Tube

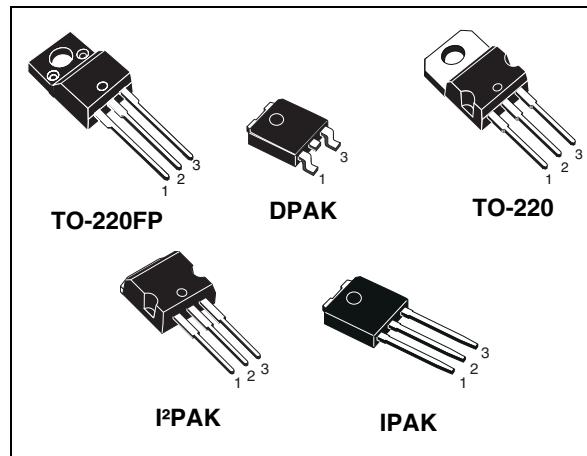
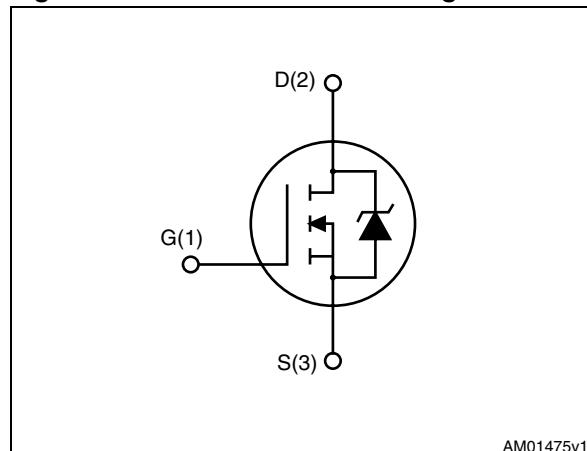


Figure 1. Internal schematic diagram



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# 1 Electrical ratings

**Table 2. Absolute maximum ratings**

Symbol	Parameter	Value		Unit
		TO-220, IPAK DPAK, I <sup>2</sup> PAK	TO-220FP	
$V_{GS}$	Gate- source voltage	$\pm 25$		V
$I_D$	Drain current (continuous) at $T_C = 25^\circ\text{C}$	7	7 <sup>(1)</sup>	A
$I_D$	Drain current (continuous) at $T_C = 100^\circ\text{C}$	4.4	4.4 <sup>(1)</sup>	A
$I_{DM}^{(2)}$	Drain current (pulsed)	28	28 <sup>(1)</sup>	A
$P_{TOT}$	Total dissipation at $T_C = 25^\circ\text{C}$	70	25	W
$I_{AR}$	Max current during repetitive or single pulse avalanche (pulse width limited by $T_{JMAX}$ )	TBD		A
$E_{AS}$	Single pulse avalanche energy (starting $T_j = 25^\circ\text{C}$ , $I_D = I_{AR}$ , $V_{DD} = 50\text{V}$ )	TBD		mJ
$dv/dt^{(3)}$	Peak diode recovery voltage slope	TBD		V/ns
$V_{ISO}$	Insulation withstand voltage (RMS) from all three leads to external heat sink ( $t = 1\text{ s}$ ; $T_c = 25^\circ\text{C}$ )		2500	V
$T_{stg}$	Storage temperature	-55 to 150		°C
$T_j$	Max. operating junction temperature	150		°C

1. Limited only by maximum temperature allowed
2. Pulse width limited by safe operating area
3.  $I_{SD} \leq 33\text{ A}$ ,  $dI/dt \leq 400\text{ A}/\mu\text{s}$ ,  $V_{Peak} < V_{(BR)DSS}$

**Table 3. Thermal data**

Symbol	Parameter	Value					Unit	
		DPAK	IPAK	TO-220	I <sup>2</sup> PAK	TO-220FP		
$R_{thj-case}$	Thermal resistance junction-case max	1.79		5		°C/W		
$R_{thj-amb}$	Thermal resistance junction-ambient max	100		62.5		°C/W		
$R_{thj-pcb}$	Thermal resistance junction-pcb max	50				°C/W		
$T_I$	Maximum lead temperature for soldering purpose	300				°C		

## 2 Electrical characteristics

( $T_C = 25^\circ\text{C}$  unless otherwise specified)

**Table 4. On /off states**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(\text{BR})\text{DSS}}$	Drain-source breakdown voltage	$I_D = 1 \text{ mA}, V_{GS} = 0$	650			V
$I_{\text{DSS}}$	Zero gate voltage drain current ( $V_{GS} = 0$ )	$V_{DS} = \text{Max rating}$ $V_{DS} = \text{Max rating}, T_C = 125^\circ\text{C}$			1 100	$\mu\text{A}$ $\mu\text{A}$
$I_{GSS}$	Gate-body leakage current ( $V_{DS} = 0$ )	$V_{GS} = \pm 25 \text{ V}$			100	nA
$V_{GS(\text{th})}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	3	4	5	V
$R_{\text{DS(on)}}$	Static drain-source on resistance	$V_{GS} = 10 \text{ V}, I_D = 3.5 \text{ A}$		0.56	0.6	$\Omega$

**Table 5. Dynamic**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$C_{iss}$	Input capacitance			TBD		pF
$C_{oss}$	Output capacitance	$V_{DS} = 100 \text{ V}, f = 1 \text{ MHz},$ $V_{GS} = 0$	-	TBD	-	pF
$C_{rss}$	Reverse transfer capacitance			TBD		pF
$C_{o(er)}^{(1)}$	Equivalent output capacitance energy related	$V_{GS} = 0, V_{DS} = 0 \text{ to } 520 \text{ V}$	-	TBD	-	pF
$C_{o(tr)}^{(2)}$	Equivalent output capacitance time related	$V_{GS} = 0, V_{DS} = 0 \text{ to } 520 \text{ V}$	-	TBD	-	pF
$R_G$	Intrinsic gate resistance	$f = 1 \text{ MHz open drain}$	-	TBD	-	$\Omega$
$Q_g$	Total gate charge	$V_{DD} = 520 \text{ V}, I_D = 3.5 \text{ A},$ $V_{GS} = 10 \text{ V}$		190		nC
$Q_{gs}$	Gate-source charge			TBD	-	nC
$Q_{gd}$	Gate-drain charge	(see <i>Figure 3</i> )		TBD		nC

- $C_{o(er)}$  is a constant capacitance value that gives the same stored energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$
- $C_{o(tr)}$  is a constant capacitance value that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$

**Table 6. Switching times**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(\text{off})}$	Turn-off delay time	$V_{DD} = 400 \text{ V}$ , $I_D = 4\text{A}$ ,		TBD		ns
$t_r$	Rise time	$R_G = 4.7 \Omega$ , $V_{GS} = 10 \text{ V}$	-	TBD	-	ns
$t_c$	Cross time	(see <i>Figure 4</i> )		TBD		ns
$t_f$	Fall time	(see <i>Figure 7</i> )		TBD		ns

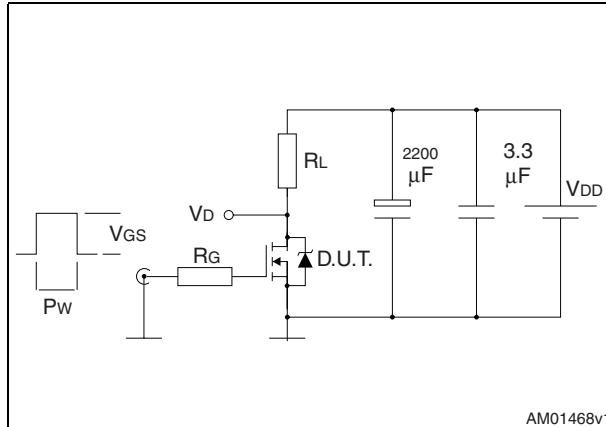
**Table 7. Source drain diode**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{SD}$	Source-drain current		-		7	A
$I_{SDM}^{(1)}$	Source-drain current (pulsed)				28	A
$V_{SD}^{(2)}$	Forward on voltage	$I_{SD} = 7 \text{ A}$ , $V_{GS} = 0$	-		1.5	V
$t_{rr}$	Reverse recovery time	$I_{SD} = 7 \text{ A}$ , $dI/dt = 100 \text{ A}/\mu\text{s}$		TBD		ns
$Q_{rr}$	Reverse recovery charge	$V_{DD} = 100 \text{ V}$	-	TBD		$\mu\text{C}$
$I_{RRM}$	Reverse recovery current	(see <i>Figure 4</i> )		TBD		A
$t_{rr}$	Reverse recovery time	$I_{SD} = 7 \text{ A}$ , $dI/dt = 100 \text{ A}/\mu\text{s}$		TBD		ns
$Q_{rr}$	Reverse recovery charge	$V_{DD} = 100 \text{ V}$	-	TBD		$\mu\text{C}$
$I_{RRM}$	Reverse recovery current	(see <i>Figure 4</i> )		TBD		A

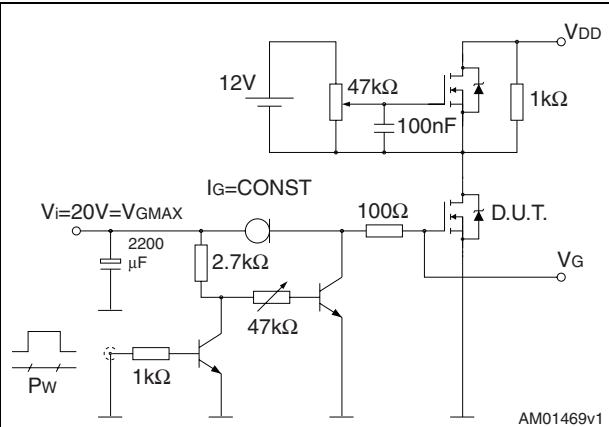
1. Pulse width limited by safe operating area
2. Pulsed: pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%

### 3 Test circuits

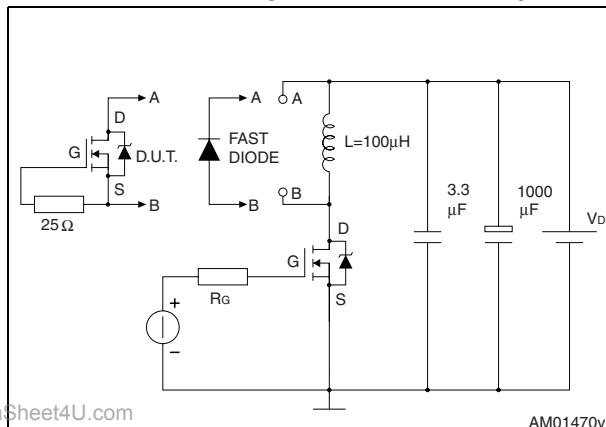
**Figure 2. Switching times test circuit for resistive load**



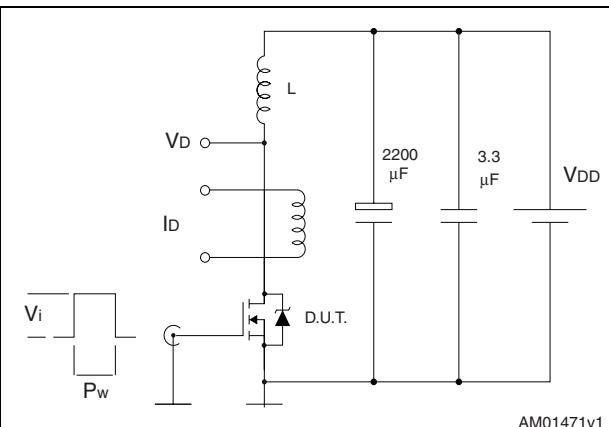
**Figure 3. Gate charge test circuit**



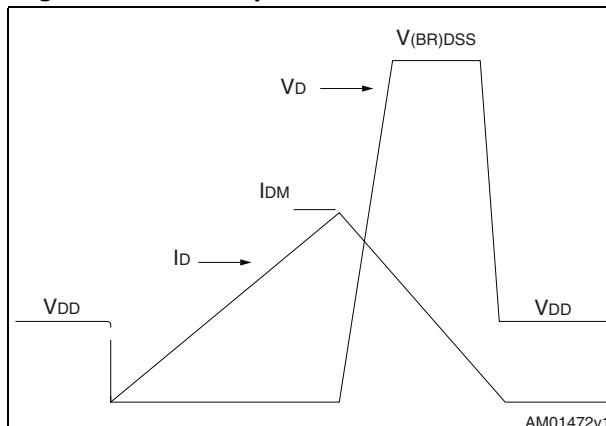
**Figure 4. Test circuit for inductive load switching and diode recovery times**



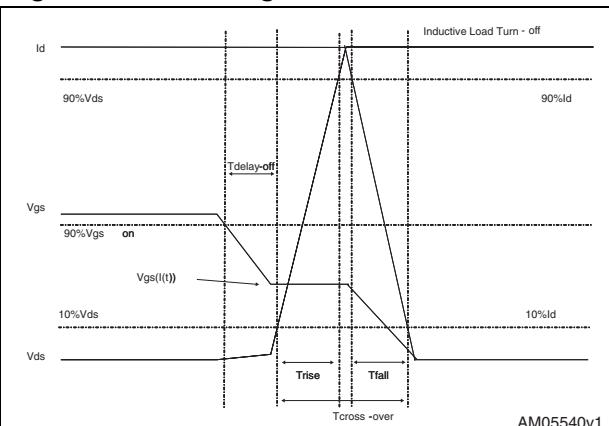
**Figure 5. Unclamped inductive load test circuit**



**Figure 6. Unclamped inductive waveform**



**Figure 7. Switching time waveform**



## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK is an ST trademark.

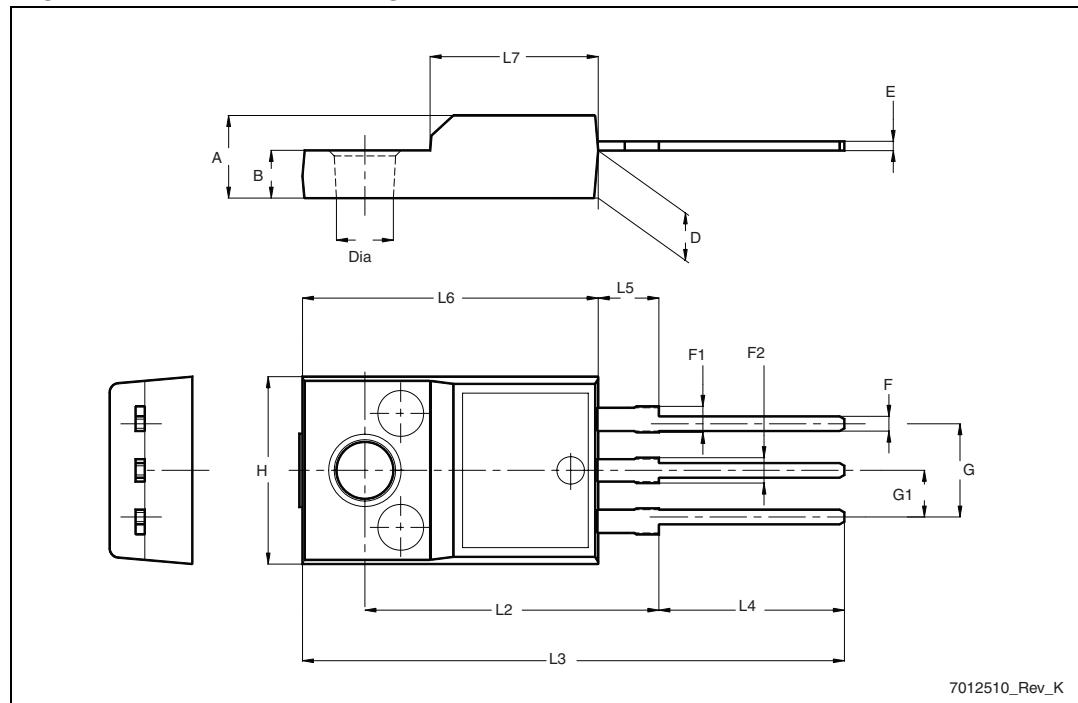
## Package mechanical data

STD/F/I/P/U8N65M5

Table 8. TO-220FP mechanical data

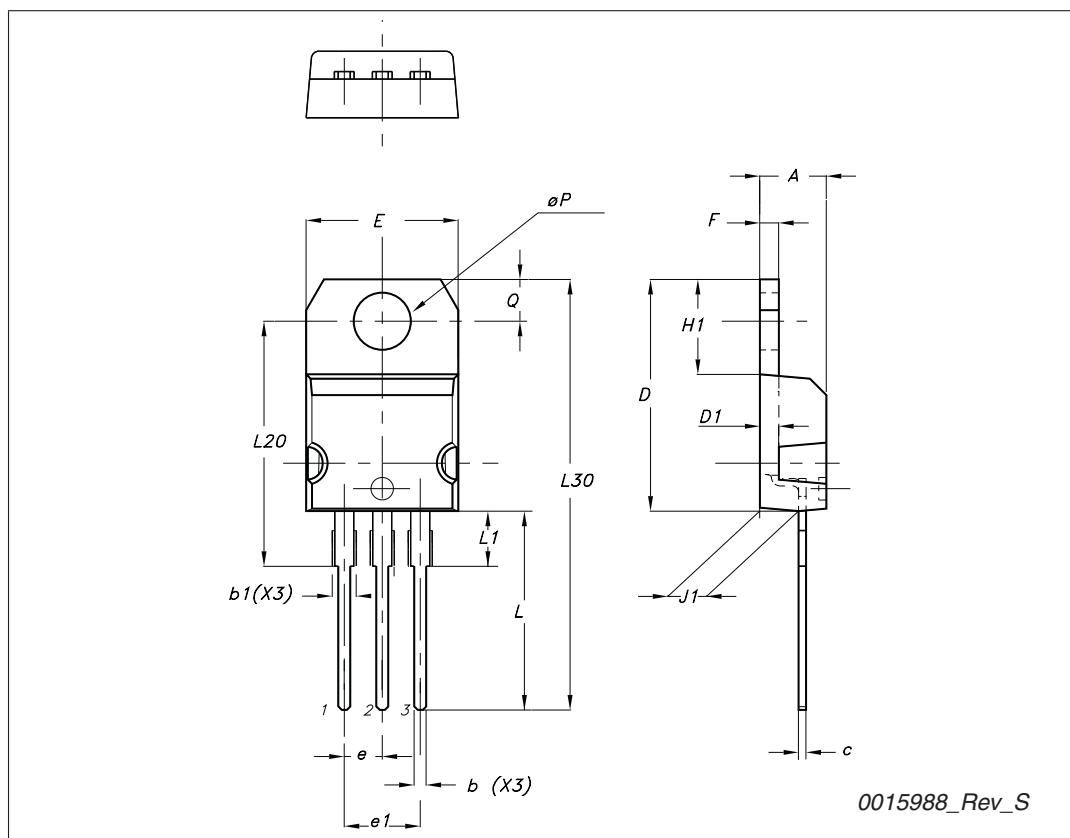
Dim.	mm		
	Min.	Typ.	Max.
A	4.4		4.6
B	2.5		2.7
D	2.5		2.75
E	0.45		0.7
F	0.75		1
F1	1.15		1.70
F2	1.15		1.70
G	4.95		5.2
G1	2.4		2.7
H	10		10.4
L2		16	
L3	28.6		30.6
L4	9.8		10.6
L5	2.9		3.6
L6	15.9		16.4
L7	9		9.3
Dia	3		3.2

Figure 8. TO-220FP drawing mechanical data



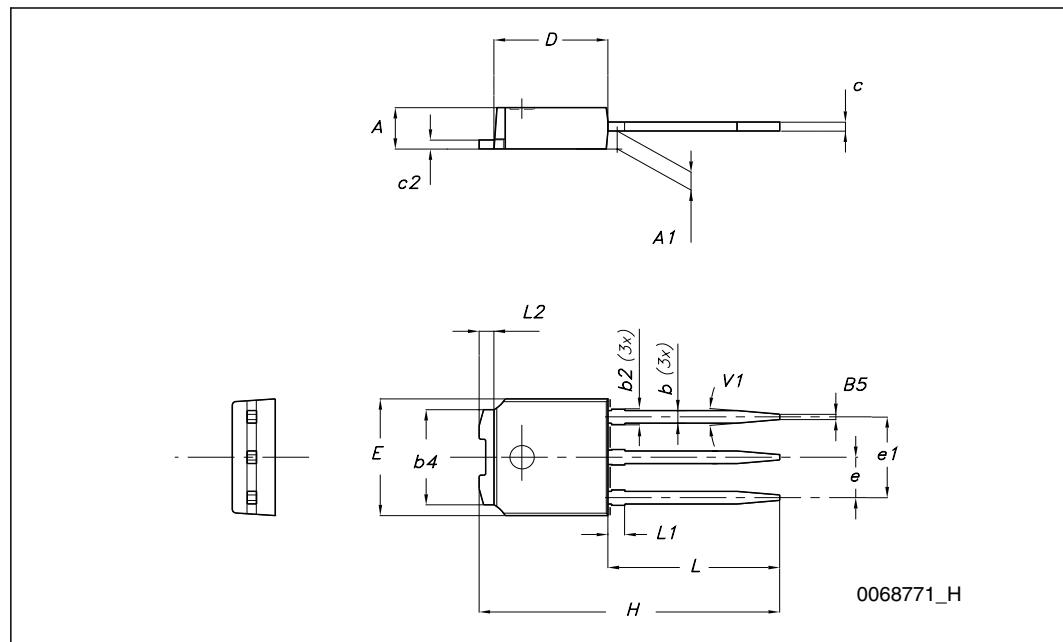
## TO-220 type A mechanical data

Dim	mm		
	Min	Typ	Max
A	4.40		4.60
b	0.61		0.88
b1	1.14		1.70
c	0.48		0.70
D	15.25		15.75
D1		1.27	
E	10		10.40
e	2.40		2.70
e1	4.95		5.15
F	1.23		1.32
H1	6.20		6.60
J1	2.40		2.72
L	13		14
L1	3.50		3.93
L20		16.40	
L30		28.90	
ØP	3.75		3.85
Q	2.65		2.95



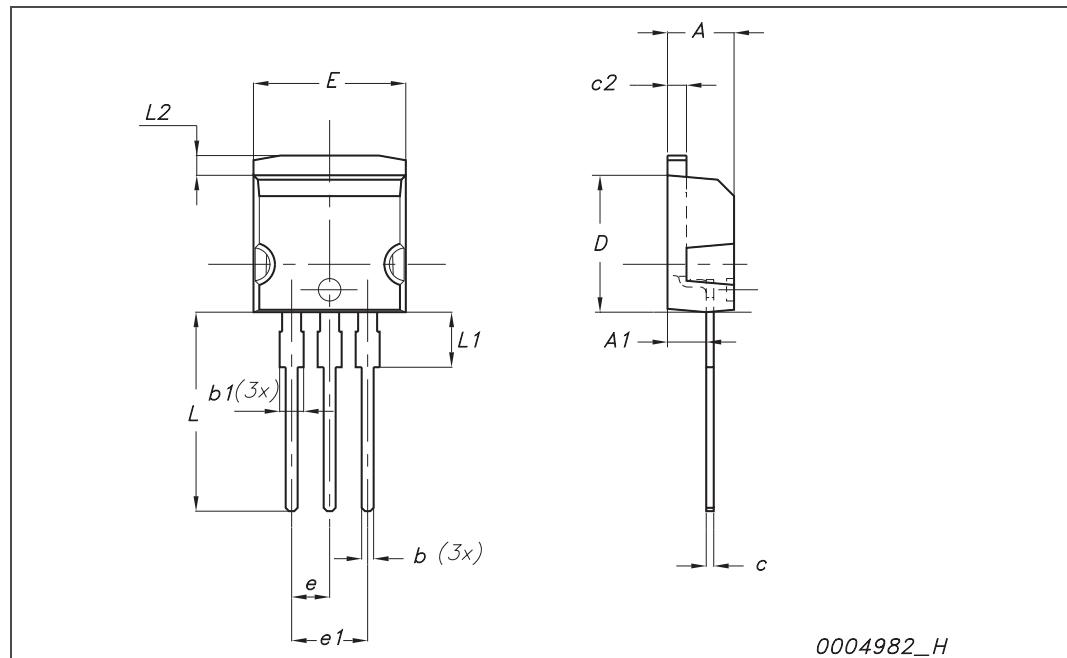
## TO-251 (IPAK) mechanical data

DIM.	mm.		
	min.	typ	max.
A	2.20		2.40
A1	0.90		1.10
b	0.64		0.90
b2			0.95
b4	5.20		5.40
c	0.45		0.60
c2	0.48		0.60
D	6.00		6.20
E	6.40		6.60
e		2.28	
e1	4.40		4.60
H		16.10	
L	9.00		9.40
(L1)	0.80		1.20
L2		0.80	
V1		10 °	



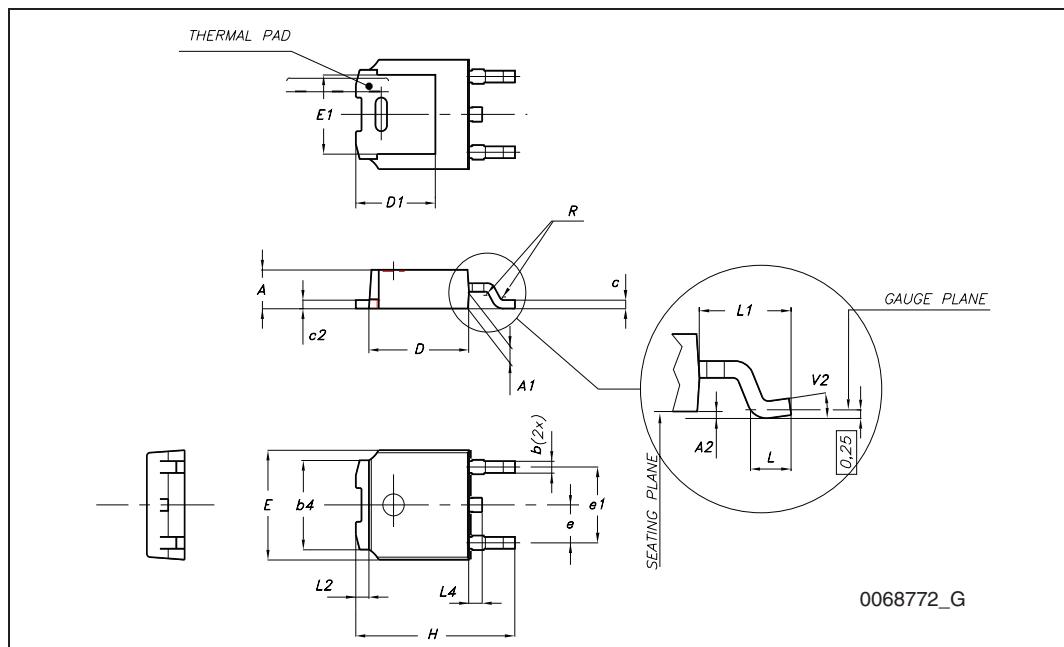
I<sup>2</sup>PAK (TO-262) mechanical data

Dim	mm			inch		
	Min	Typ	Max	Min	Typ	Max
A	4.40		4.60	0.173		0.181
A1	2.40		2.72	0.094		0.107
b	0.61		0.88	0.024		0.034
b1	1.14		1.70	0.044		0.066
c	0.49		0.70	0.019		0.027
c2	1.23		1.32	0.048		0.052
D	8.95		9.35	0.352		0.368
e	2.40		2.70	0.094		0.106
e1	4.95		5.15	0.194		0.202
E	10		10.40	0.393		0.410
L	13		14	0.511		0.551
L1	3.50		3.93	0.137		0.154
L2	1.27		1.40	0.050		0.055



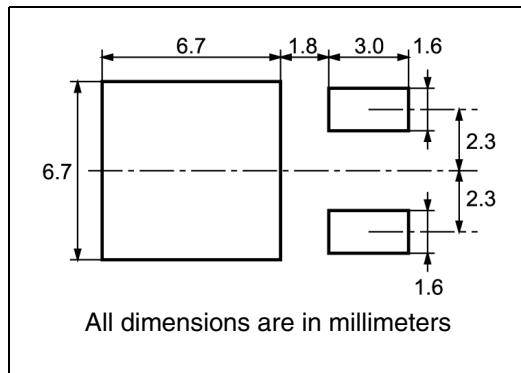
## TO-252 (DPAK) mechanical data

DIM.	mm.		
	min.	typ	max.
A	2.20		2.40
A1	0.90		1.10
A2	0.03		0.23
b	0.64		0.90
b4	5.20		5.40
c	0.45		0.60
c2	0.48		0.60
D	6.00		6.20
D1		5.10	
E	6.40		6.60
E1		4.70	
e		2.28	
e1	4.40		4.60
H	9.35		10.10
L	1		
L1		2.80	
L2		0.80	
L4	0.60		1
R		0.20	
V2	0 °		8 °

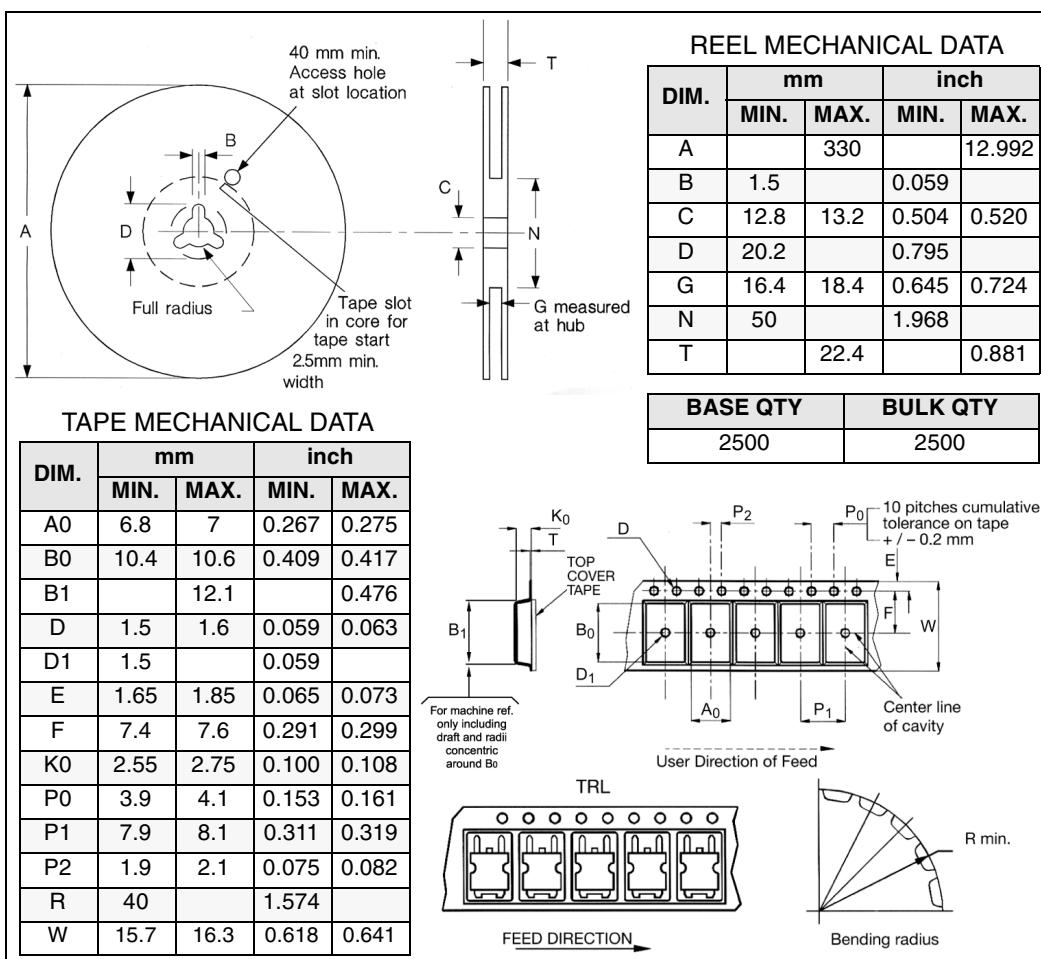


## 5 Packaging mechanical data

### DPAK FOOTPRINT



### TAPE AND REEL SHIPMENT



## 6 Revision history

**Table 9. Document revision history**

Date	Revision	Changes
23-Oct-2009	1	First release

## STD/F/I/P/U8N65M5

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